

RoHS

AP2765I-A-HF-VB Datasheet N-Channel 650V (D-S) Power MOSFET

| PRODUCT SUMMARY | | | | |
|--|-----------------|------|--|--|
| V _{DS} (V) at T _J max. | 650 |) | | |
| R _{DS(on)} at 25 °C (Ω) | $V_{GS} = 10 V$ | 0.82 | | |
| Q _g max. (nC) | 57 | | | |
| Q _{gs} (nC) | 4.0 | | | |
| Q _{gd} (nC) | 5.4 | | | |
| Configuration | Single | | | |

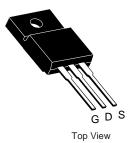
FEATURES

- Low figure-of-merit (FOM) Ron x Qa
- Low input capacitance (Ciss)
- · Reduced switching and conduction losses
- Ultra low gate charge (Q_q)
- Avalanche energy rated (UIS)

APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
- Fluorescent ballast lighting
- Industrial

TO-220 FULLPAK



N-Channel MOSFET

| PARAMETER | | | SYMBOL | LIMIT | UNIT |
|--|-------------------------|---|-----------------------------------|--------------|------|
| Drain-Source Voltage | | | V _{DS} | 650 | V |
| Gate-Source Voltage | | | V _{GS} | ± 30 | - V |
| Continuous Drain Current (T ₁ = 150 °C) | V _{GS} at 10 V | $T_{\rm C} = 25 \ ^{\circ}{\rm C}$ $T_{\rm C} = 100 \ ^{\circ}{\rm C}$ | L | 10 | |
| Continuous Drain Current $(1_j = 150 \text{ C})$ | VGS at 10 V | T _C = 100 °C | ID | 8 | A |
| Pulsed Drain Current ^a | | | I _{DM} | 35 | |
| Linear Derating Factor | | | | 1.67/1.5/0.3 | W/°C |
| Single Pulse Avalanche Energy ^b | | | E _{AS} | 86 | mJ |
| Maximum Power Dissipation | | | P _D | 178/156/53 | W |
| Operating Junction and Storage Temperature Range | e | | T _J , T _{stg} | -55 to +150 | °C |
| Drain-Source Voltage Slope $T_J = 125 \text{ °C}$ | | | N // 11 | 50 | |
| Reverse Diode dV/dt ^d | | | dV/dt | 4.5 | V/ns |
| Soldering Recommendations (Peak Temperature) c | for | 10 s | | 300 | °C |

N

a. Repetitive rating; pulse width limited by maximum junction temperature. b. V_{DD} = 50 V, starting T_J = 25 °C, L = 28.2 mH, R_g = 25 Ω , I_{AS} = 3.5 A.

c. 1.6 mm from case. d. $I_{SD} \le I_D$, dl/dt = 100 A/µs, starting $T_J = 25$ °C.

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| A | 3 | R V | Bs | em | i |
|----|------|--------|-----|-------|---|
| WV | vw.\ | /Bs | sem | i.con | n |

| THERMAL RESISTANCE RAT | INGS | | | |
|----------------------------------|-------------------|------|------|------|
| PARAMETER | SYMBOL | TYP. | MAX. | UNIT |
| Maximum Junction-to-Ambient | R _{thJA} | - | 63 | °C/W |
| Maximum Junction-to-Case (Drain) | R _{thJC} | - | 0.6 | 0/10 |

| PARAMETER | SYMBOL | TEST CONDITIONS | | MIN. | TYP. | MAX. | UNIT |
|--|-----------------------|--|--|------|------|-------|-------|
| Static | | | | | | | |
| Drain-Source Breakdown Voltage | V _{DS} | V _{GS} = | = 0 V, I _D = 250 μA | 650 | - | - | V |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | Reference | e to 25 °C, I _D = 1 mA | - | 0.65 | - | V/°C |
| Gate-Source Threshold Voltage (N) | V _{GS(th)} | V _{DS} = | = V _{GS} , I _D = 250 μΑ | 2 | - | 4 | V |
| | | | V _{GS} = ± 20 V | - | - | ± 100 | nA |
| Gate-Source Leakage | I _{GSS} | | $V_{GS} = \pm 30 \text{ V}$ | - | - | ± 1 | μA |
| | | | = 650 V, V _{GS} = 0 V | - | - | 1 | P"''' |
| Zero Gate Voltage Drain Current | I _{DSS} | | /, V _{GS} = 0 V, T _J = 125 °C | - | _ | 10 | μA |
| Drain-Source On-State Resistance | R _{DS(on)} | V _{GS} = 10 V | $I_D = 4 A$ | - | 0.82 | - | Ω |
| Forward Transconductance | 9 _{fs} | | $_{\rm s} = 30 \text{ V}, \text{ I}_{\rm D} = 4 \text{ A}$ | - | 16 | - | S |
| Dynamic | 0.0 | | | 1 | 1 | 1 | - |
| Input Capacitance | C _{iss} | | V 0.V | - | 1900 | - | |
| Output Capacitance | C _{oss} | $V_{GS} = 0 V_{CS}$ | | - | | | |
| Reverse Transfer Capacitance | Crss | - | | - | | - | pF |
| Effective Output Capacitance, Energy Related ^a | C _{o(er)} | | | - | 45 | - | |
| Effective Output Capacitance, Time Related ^b | C _{o(tr)} | - V _{DS} = 0 V | / to 520 V, $V_{GS} = 0 V$ | - | 62 | - | |
| Total Gate Charge | Qg | | | - | 40 | 57 | nC |
| Gate-Source Charge | Q _{gs} | $V_{GS} = 10 V$ | $I_D = 4 \text{ A}, V_{DS} = 520 \text{ V}$ | - | 4.0 | - | |
| Gate-Drain Charge | Q _{gd} | | | - | 5.4 | - | |
| Turn-On Delay Time | t _{d(on)} | | | - | 25 | - | |
| Rise Time | t _r | V _{DD} = 520 V, I _D = 4 A, | | - | 55 | - | 1 |
| Turn-Off Delay Time | t _{d(off)} | | $= 10 \text{ V}, \text{ R}_{g} = 9.1 \Omega$ | - | 70 | - | - ns |
| Fall Time | t _f | | | - | 40 | - | |
| Gate Input Resistance | Rg | f = 1 | MHz, open drain | - | 3.5 | - | Ω |
| Drain-Source Body Diode Characteristic | s | | | | • | | |
| Continuous Source-Drain Diode Current | I _S | MOSFET symbol 7 | | | | | |
| Pulsed Diode Forward Current | I _{SM} | ũ | integral reverse p - n junction diode | | - | 18 | A |
| Diode Forward Voltage | V _{SD} | T _J = 25 ° | C, I _S = 4 A, V _{GS} = 0 V | - | - | 1.5 | V |
| Reverse Recovery Time | t _{rr} | | | - | 190 | - | ns |
| Reverse Recovery Charge | Q _{rr} | $T_{I} = 25 \text{ °C}, I_{E} = I_{S} = 4 \text{ A},$ | | - | μC | | |
| Reverse Recovery Current | I _{RRM} | $dl/dt = 100 \text{ A}/\mu \text{s}, \text{ V}_{\text{R}} = 400 \text{ V}$ | | 10 | | A | |

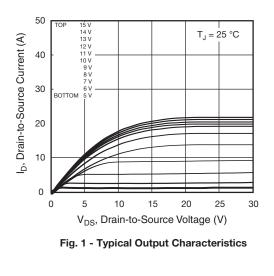
Notes

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .

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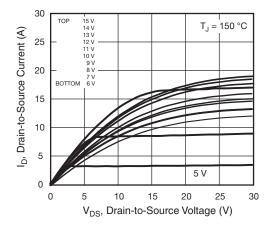


Fig. 2 - Typical Output Characteristics

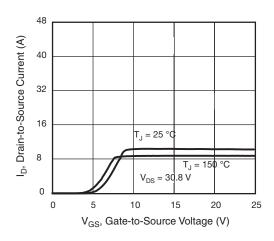


Fig. 3 - Typical Transfer Characteristics

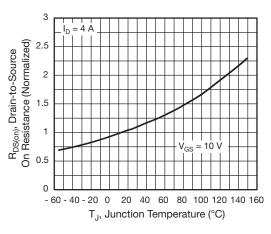


Fig. 4 - Normalized On-Resistance vs. Temperature

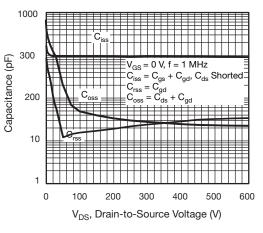


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

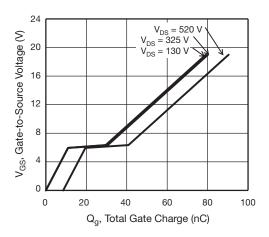


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

AP2765I-A-HF-VB



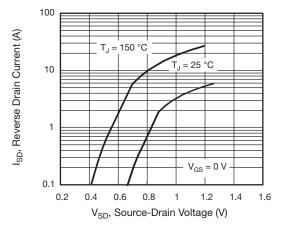


Fig. 7 - Typical Source-Drain Diode Forward Voltage



Fig. 8 - Maximum Safe Operating Area

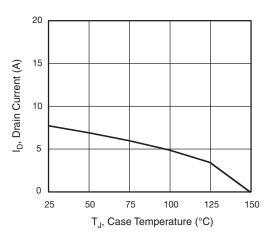


Fig. 9 - Maximum Drain Current vs. Case Temperature

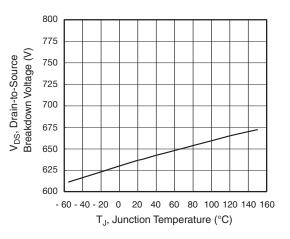


Fig. 10 - Temperature vs. Drain-to-Source Voltage



Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case



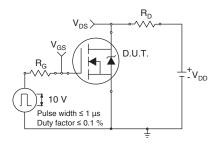


Fig. 12 - Switching Time Test Circuit

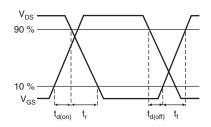


Fig. 13 - Switching Time Waveforms

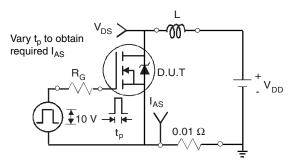


Fig. 14 - Unclamped Inductive Test Circuit



Fig. 15 - Unclamped Inductive Waveforms

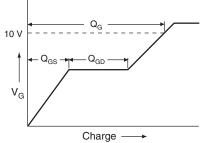


Fig. 16 - Basic Gate Charge Waveform

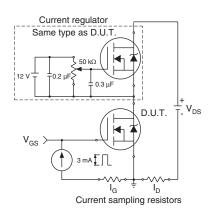
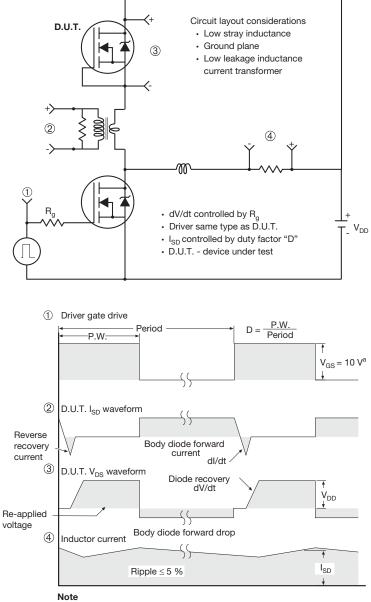


Fig. 17 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

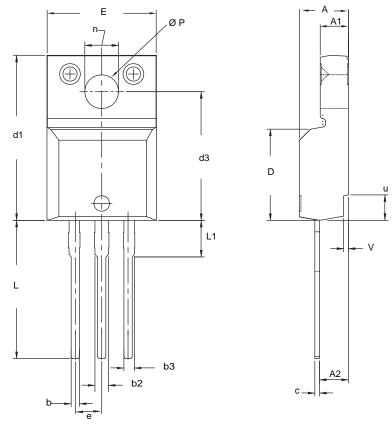


a. $V_{GS} = 5 V$ for logic level devices

Fig. 18 - For N-Channel



TO-220 FULLPAK (HIGH VOLTAGE)



| | MILLIN | MILLIMETERS | | INCHES | | |
|------|--------|-------------|-----------|--------|--|--|
| DIM. | MIN. | MAX. | MIN. | MAX. | | |
| А | 4.570 | 4.830 | 0.180 | 0.190 | | |
| A1 | 2.570 | 2.830 | 0.101 | 0.111 | | |
| A2 | 2.510 | 2.850 | 0.099 | 0.112 | | |
| b | 0.622 | 0.890 | 0.024 | 0.035 | | |
| b2 | 1.229 | 1.400 | 0.048 | 0.055 | | |
| b3 | 1.229 | 1.400 | 0.048 | 0.055 | | |
| С | 0.440 | 0.629 | 0.017 | 0.025 | | |
| D | 8.650 | 9.800 | 0.341 | 0.386 | | |
| d1 | 15.88 | 16.120 | 0.622 | 0.635 | | |
| d3 | 12.300 | 12.920 | 0.484 | 0.509 | | |
| E | 10.360 | 10.630 | 0.408 | 0.419 | | |
| е | 2.54 | BSC | 0.100 BSC | | | |
| L | 13.200 | 13.730 | 0.520 | 0.541 | | |
| L1 | 3.100 | 3.500 | 0.122 | 0.138 | | |
| n | 6.050 | 6.150 | 0.238 | 0.242 | | |
| Ø P | 3.050 | 3.450 | 0.120 | 0.136 | | |
| u | 2.400 | 2.500 | 0.094 | 0.098 | | |
| V | 0.400 | 0.500 | 0.016 | 0.020 | | |

Notes

1. To be used only for process drawing. 2. These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads. 3. All critical dimensions should C meet $C_{pk} > 1.33$. 4. All dimensions include burrs and plating thickness.

5. No chipping or package damage.

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